

SCAN18541T Non-Inverting Line Driver with 3-STATE Outputs

General Description

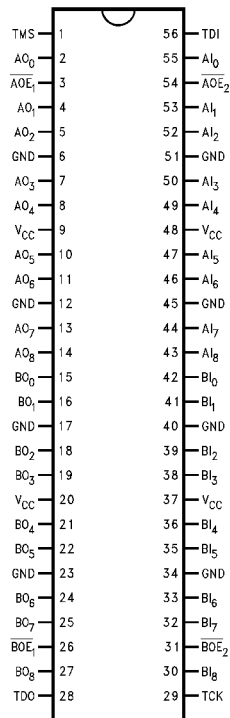
The SCAN18541T is a high speed, low-power line driver featuring separate data inputs organized into dual 9-bit bytes with byte-oriented paired output enable control signals. This device is compliant with IEEE 1149.1 Standard Test Access Port and Boundary Scan Architecture with the incorporation of the defined boundary-scan test logic and test access port consisting of Test Data Input (TDI), Test Data Out (TDO), Test Mode Select (TMS), and Test Clock (TCK).

Features

- IEEE 1149.1 (JTAG) Compliant

- Dual output enable signals per byte
- 3-STATE outputs for bus-oriented applications
- 9-bit data busses for parity applications
- Reduced-swing outputs source 32 mA/sink 64 mA (Comm), source 24 mA/sink 48 mA (Mil)
- Guaranteed to drive 50Ω transmission line to TTL input levels of 0.8V and 2.0V
- TTL compatible inputs
- 25 mil pitch SSOP (Shrink Small Outline Package)
- Includes CLAMP and HIGHZ instructions
- Member of Fairchild's SCAN Products

Ordering Code: Connection Diagram



Pin Names

| Pin Names | Description |
|--|--|
| AI ₍₀₋₈₎ | Input Pins, A Side |
| BI ₍₀₋₈₎ | Input Pins, B Side |
| AOE ₁ , AOE ₂ | 3-STATE Output Enable Input Pins, A Side |
| BOE ₁ , BOE ₂ | 3-STATE Output Enable Input Pins, B Side |
| AO ₍₀₋₈₎ | Output Pins, A Side |
| BO ₍₀₋₈₎ | Output Pins, B Side |

SCAN18541T Non-Inverting Line Driver with 3-STATE Outputs

Truth Tables

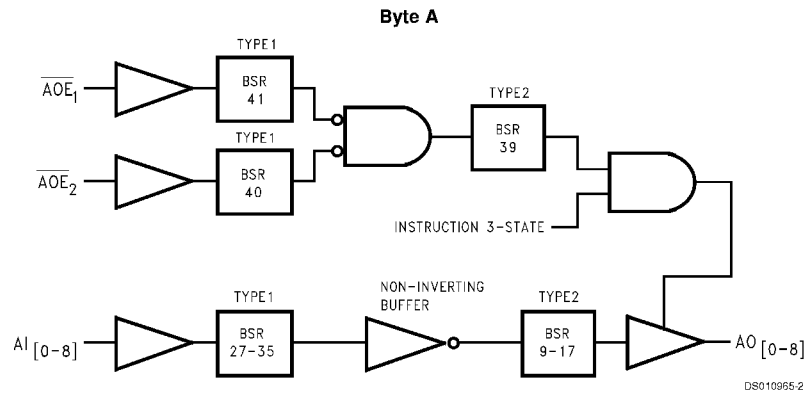
| Inputs | | | AO (0-8) |
|--------------------|--------------------|----------|----------|
| $\overline{AOE_1}$ | $\overline{AOE_2}$ | AI (0-8) | |
| L | L | H | H |
| H | X | X | Z |
| X | H | X | Z |
| L | L | L | L |

| Inputs | | | BO (0-8) |
|--------------------|--------------------|----------|----------|
| $\overline{BOE_1}$ | $\overline{BOE_2}$ | BI (0-8) | |
| L | L | H | H |
| H | X | X | Z |
| X | H | X | Z |
| L | L | L | L |

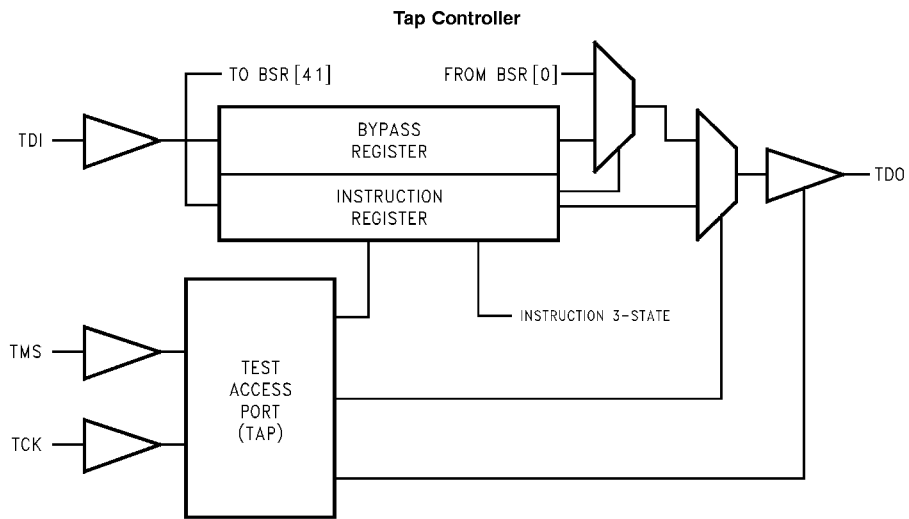
H= HIGH Voltage Level
 L= LOW Voltage Level
 X= Immaterial
 Z= High Impedance

| Order Number | Description |
|-----------------|-----------------------|
| SCAN18541TSSC | SSOP in Tubes |
| SCAN18541TSSCX | SSOP in Tape and Reel |
| SCAN18541TFMQB | Flatpak Military |
| 5962-9311601MXA | Military SMD# |

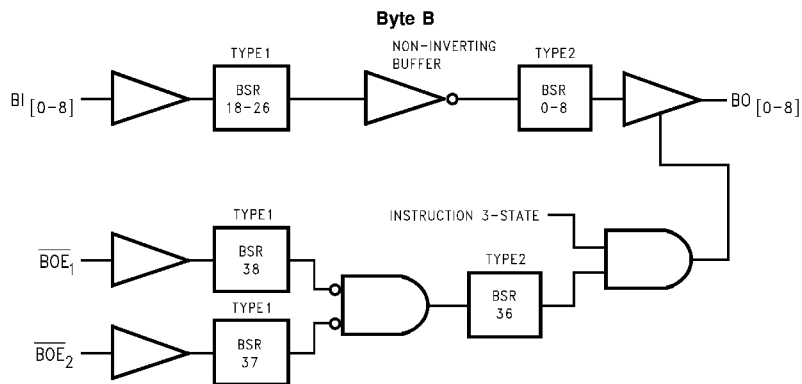
Block Diagrams



Block Diagrams (Continued)



DS010965-3



DS010965-4

Note: BSR stands for Boundary Scan Register.

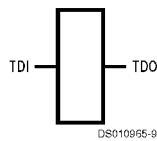
Description of Boundary-Scan Circuitry

The scan cells used in the BOUNDARY-SCAN register are one of the following two types depending upon their location. Scan cell TYPE1 is intended to solely observe system data, while TYPE2 has the additional ability to control system data. (See IEEE Standard 1149.1 *Figure 10-11* for a further description of scan cell TYPE1 and *Figure 10-12* for a further description of scan cell TYPE2.)

Scan cell TYPE1 is located on each system input pin while scan cell TYPE2 is located at each system output pin as well as at each of the two internal active-high output enable signals. AOE controls the activity of the A-outputs while BOE controls the activity of the B-outputs. Each will activate their respective outputs by loading a logic high.

The BYPASS register is a single bit shift register stage identical to scan cell TYPE1. It captures a fixed logic low.

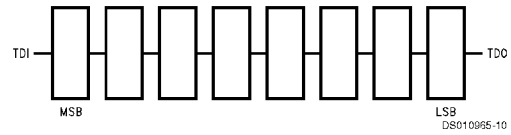
Bypass Register Scan Chain Definition Logic 0



The INSTRUCTION register is an 8-bit register which captures the default value of 10000001. The two least significant bits of this captured value (01) are required by IEEE Std 1149.1. The upper six bits are unique to the SCAN18541T

device. SCAN CMOS Test Access Logic devices do not include the IEEE 1149.1 optional identification register. Therefore, this unique captured value can be used as a "pseudo ID" code to confirm that the correct device is placed in the appropriate location in the boundary scan chain.

Instruction Register Scan Chain Definition

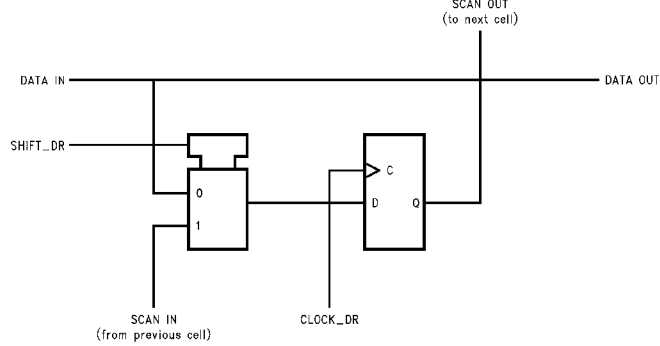


MSB→LSB

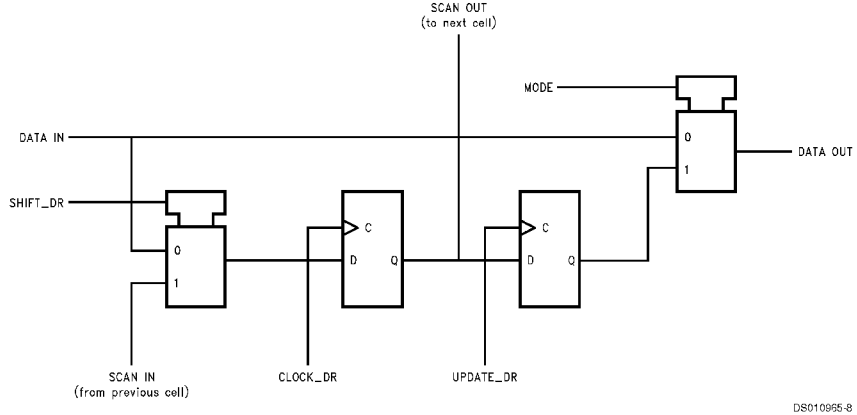
| Instruction Code | Instruction |
|------------------|----------------|
| 00000000 | EXTEST |
| 10000001 | SAMPLE/PRELOAD |
| 10000010 | CLAMP |
| 00000011 | HIGH-Z |
| All Others | BYPASS |

Description of Boundary-Scan Circuitry (Continued)

Scan Cell TYPE1

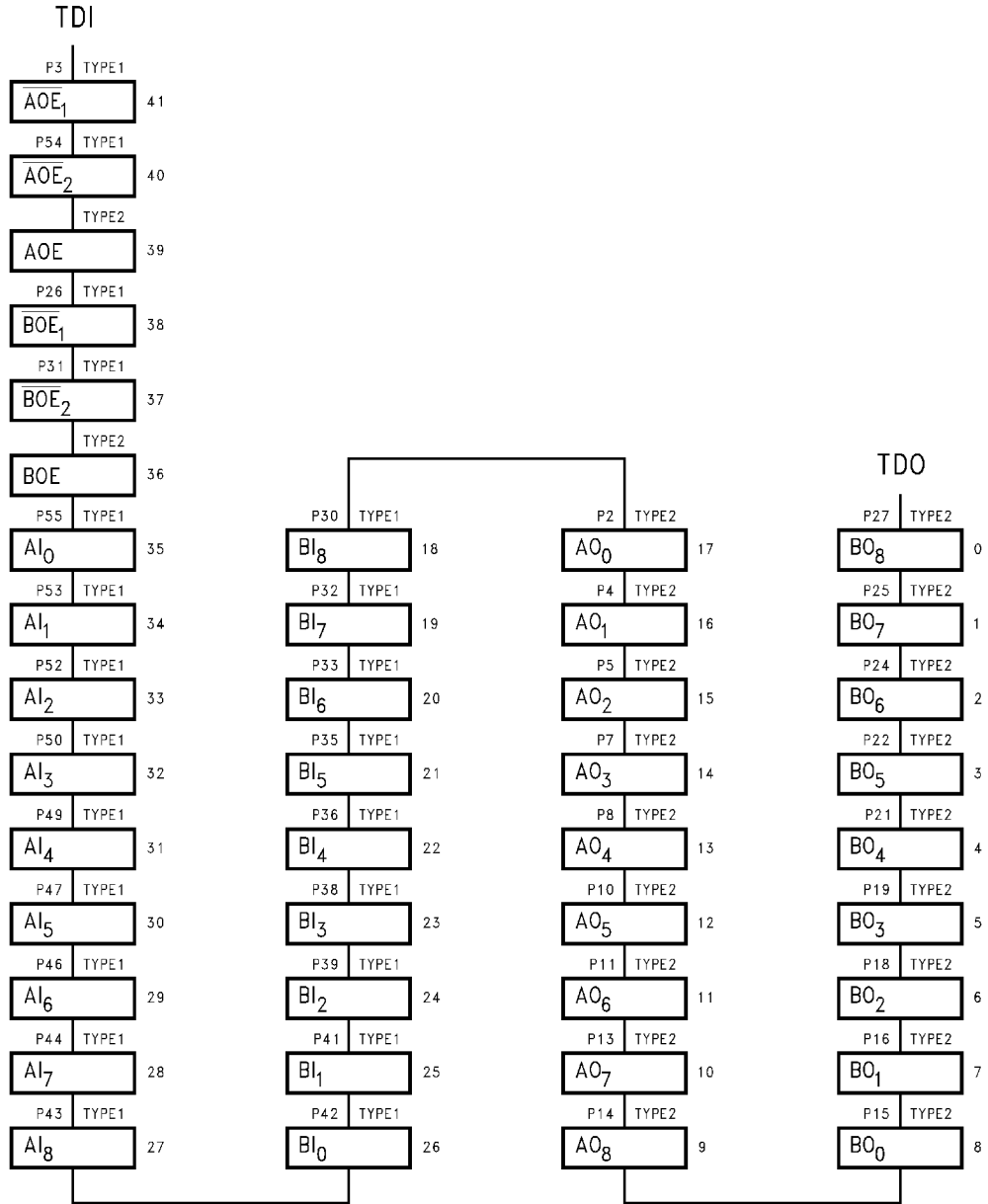


Scan Cell TYPE2



Description of Boundary-Scan Circuitry (Continued)

Boundary-Scan Register Scan Chain Definition (42 Bits in Length)



DS010955-23

Description of Boundary-Scan Circuitry (Continued)

Boundary-Scan Register Definition Index

| Bit No. | Pin Name | Pin No. | Pin Type | Scan Cell Type | |
|---------|--------------------|---------|----------|----------------|-----------------|
| 41 | \overline{AOE}_1 | 3 | Input | TYPE1 | Control Signals |
| 40 | \overline{AOE}_2 | 54 | Input | TYPE1 | |
| 39 | AOE | | Internal | TYPE2 | |
| 38 | \overline{BOE}_1 | 26 | Input | TYPE1 | |
| 37 | \overline{BOE}_2 | 31 | Input | TYPE1 | |
| 36 | BOE | | Internal | TYPE2 | |
| 35 | AI ₀ | 55 | Input | TYPE1 | A-in |
| 34 | AI ₁ | 53 | Input | TYPE1 | |
| 33 | AI ₂ | 52 | Input | TYPE1 | |
| 32 | AI ₃ | 50 | Input | TYPE1 | |
| 31 | AI ₄ | 49 | Input | TYPE1 | |
| 30 | AI ₅ | 47 | Input | TYPE1 | |
| 29 | AI ₆ | 46 | Input | TYPE1 | |
| 28 | AI ₇ | 44 | Input | TYPE1 | |
| 27 | AI ₈ | 43 | Input | TYPE1 | |
| 26 | BI ₀ | 42 | Input | TYPE1 | B-in |
| 25 | BI ₁ | 41 | Input | TYPE1 | |
| 24 | BI ₂ | 39 | Input | TYPE1 | |
| 23 | BI ₃ | 38 | Input | TYPE1 | |
| 22 | BI ₄ | 36 | Input | TYPE1 | |
| 21 | BI ₅ | 35 | Input | TYPE1 | |
| 20 | BI ₆ | 33 | Input | TYPE1 | |
| 19 | BI ₇ | 32 | Input | TYPE1 | |
| 18 | BI ₈ | 30 | Input | TYPE1 | |
| 17 | AO ₀ | 2 | Output | TYPE2 | A-out |
| 16 | AO ₁ | 4 | Output | TYPE2 | |
| 15 | AO ₂ | 5 | Output | TYPE2 | |
| 14 | AO ₃ | 7 | Output | TYPE2 | |
| 13 | AO ₄ | 8 | Output | TYPE2 | |
| 12 | AO ₅ | 10 | Output | TYPE2 | |
| 11 | AO ₆ | 11 | Output | TYPE2 | |
| 10 | AO ₇ | 13 | Output | TYPE2 | |
| 9 | AO ₈ | 14 | Output | TYPE2 | |
| 8 | BO ₀ | 15 | Output | TYPE2 | B-out |
| 7 | BO ₁ | 16 | Output | TYPE2 | |
| 6 | BO ₂ | 18 | Output | TYPE2 | |
| 5 | BO ₃ | 19 | Output | TYPE2 | |
| 4 | BO ₄ | 21 | Output | TYPE2 | |
| 3 | BO ₅ | 22 | Output | TYPE2 | |
| 2 | BO ₆ | 24 | Output | TYPE2 | |
| 1 | BO ₇ | 25 | Output | TYPE2 | |
| 0 | BO ₈ | 27 | Output | TYPE2 | |

Absolute Maximum Ratings (Note 1)

| | |
|---|--------------------------|
| Supply Voltage (V_{CC}) | -0.5V to +7.0V |
| DC Input Diode Current (I_{IK}) | |
| $V_I = -0.5V$ | -20 mA |
| $V_I = V_{CC} + 0.5V$ | +20 mA |
| DC Output Diode Current (I_{OK}) | |
| $V_O = -0.5V$ | -20 mA |
| $V_O = V_{CC} + 0.5V$ | +20 mA |
| DC Output Voltage (V_O) | -0.5V to $V_{CC} + 0.5V$ |
| DC Output Source/Sink Current (I_O) | ± 70 mA |
| DC V_{CC} or Ground Current | |
| Per Output Pin | ± 70 mA |
| Junction Temperature | |
| SSOP | +140°C |
| Storage Temperature | -65°C to +150°C |
| ESD (Min) | 2000V |

Recommended Operating Conditions

| | | |
|---------------------------------|---------------|-----------------|
| Supply Voltage (V_{CC}) | SCAN Products | 4.5V to 5.5V |
| Input Voltage (V_I) | | 0V to V_{CC} |
| Output Voltage (V_O) | | 0V to V_{CC} |
| Operating Temperature (T_A) | | |
| Commercial | | -40°C to +85°C |
| Military | | -55°C to +125°C |
| Minimum Input Edge Rate dV/dt | | 125 mV/ns |
| V_{IN} from 0.8V to 2.0V | | |
| V_{CC} @ 4.5V, 5.5V | | |

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of SCAN circuits outside databook specifications.

DC Electrical Characteristics

| Symbol | Parameter | V_{CC} (V) | Commercial | | | Military | | Units | Conditions |
|----------------------|--------------------------------|-----------------|---------------------------|-------------------|--|----------|---|-------------|--|
| | | | $T_A = +25^\circ\text{C}$ | | $T_A = -55^\circ\text{C to } +125^\circ\text{C}$ | | $T_A = -40^\circ\text{C to } +85^\circ\text{C}$ | | |
| | | | Typ | Guaranteed Limits | | | | | |
| V_{IH} | Minimum High Input Voltage | 4.5 | 1.5 | 2.0 | 2.0 | | 2.0 | V | $V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$ |
| | | 5.5 | 1.5 | 2.0 | 2.0 | | 2.0 | | |
| V_{IL} | Maximum Low Input Voltage | 4.5 | 1.5 | 0.8 | 0.8 | | 0.8 | V | $V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$ |
| | | 5.5 | 1.5 | 0.8 | 0.8 | | 0.8 | | |
| V_{OH} | Minimum High Output Voltage | 4.5 | | 3.15 | 3.15 | | 3.15 | V | $I_{OUT} = -50 \mu A$ |
| | | 5.5 | | 4.15 | 4.15 | | 4.15 | | |
| | | 4.5 | | 2.4 | | | 2.4 | V | $V_{IN} = V_{IL}$ or V_{IH} $I_{OH} = -32 \text{ mA}$ |
| | | 5.5 | | 2.4 | | | 2.4 | | |
| | | 4.5 | | 2.4 | 2.4 | | | | |
| 5.5 | | 2.4 | 2.4 | | | | | | |
| V_{OL} | Maximum Low Output Voltage | 4.5 | | 0.1 | 0.1 | | 0.1 | V | $I_{OUT} = 50 \mu A$ |
| | | 5.5 | | 0.1 | 0.1 | | 0.1 | | |
| | | 4.5 | | 0.55 | | | 0.55 | V | $V_{IN} = V_{IL}$ or V_{IH} $I_{OL} = 64 \text{ mA}$ |
| | | 5.5 | | 0.55 | | | 0.55 | | |
| | | 4.5 | | 0.55 | 0.55 | | | | |
| 5.5 | | 0.55 | 0.55 | | | | | | |
| I_{IN} | Maximum Input Leakage Current | 5.5 | | ± 0.1 | ± 1.0 | | ± 1.0 | μA | $V_I = V_{CC}, \text{GND}$ |
| I_{IN} TDI, TMS | Maximum Input Leakage | 5.5 | | 2.8 | 3.7 | | 3.6 | μA | $V_I = V_{CC}$ |
| | | | | -385 | -385 | | -385 | μA | $V_I = \text{GND}$ |
| | | 5.5 | | -160 | -160 | | -160 | μA | $V_I = \text{GND}$ |
| I_{OLD} | Minimum Dynamic (Note 2) | 5.5 | | 94 | 63 | | 94 | mA | $V_{OLD} = 0.8V \text{ Max}$ |
| I_{OHD} | Output Current | | | -40 | -27 | | -40 | mA | $V_{OHD} = 2.0V \text{ Min}$ |
| I_{OZ} | Maximum Output Leakage Current | 5.5 | | ± 0.5 | ± 10.0 | | ± 5.0 | μA | $V_I (\text{OE}) = V_{IL}, V_{IH}$ |
| I_{OS} | Output Short Circuit Current | 5.5 | | -100 | -100 | | -100 | mA (min) | $V_O = 0V$ |

DC Electrical Characteristics (Continued)

| Symbol | Parameter | V _{CC} (V) | Commercial | Military | Commercial | Units | Conditions |
|------------------|-----------------------------------|------------------------|------------------------|----------------------------------|---------------------------------|-------|---|
| | | | T _A = +25°C | T _A = -55°C to +125°C | T _A = -40°C to +85°C | | |
| | | | Typ | Guaranteed Limits | | | |
| I _{CC} | Maximum Quiescent Supply Current | 5.5 | 16.0 | 168 | 88 | μA | V _O = Open TDI, TMS = V _{CC} |
| | | 5.5 | 750 | 930 | 820 | μA | V _O = Open TDI, TMS = GND |
| I _{CC1} | Maximum I _{CC} Per Input | 5.5 | 2.0 | 2.0 | 2.0 | mA | V _I = V _{CC} -2.1V |
| | | 5.5 | 2.15 | 2.15 | 2.15 | mA | V _I = V _{CC} -2.1V TDI/TMS Pin, Test One with the Other Floating |

Note 2: Maximum test duration 2.0 ms, one output loaded at a time.

Note 3: All outputs loaded; thresholds associated with output under test.

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

Noise Specifications

| Symbol | Parameter | V _{CC} (V) | Commercial | Military | Commercial | Units | |
|------------------|---|------------------------|------------------------|----------------------------------|---------------------------------|-------|---|
| | | | T _A = +25°C | T _A = -55°C to +125°C | T _A = -40°C to +85°C | | |
| | | | Typ | Guaranteed Limits | | | |
| V _{OLP} | Maximum High Output Noise (Notes 6, 7) | 5.0 | 1.0 | 1.5 | | V | |
| V _{OLV} | Minimum Low Output Noise (Notes 6, 7) | 5.0 | -0.6 | -1.2 | | V | |
| V _{OHP} | Maximum Overshoot (Notes 5, 6) | 5.0 | V _{OH} +1.0 | V _{OH} +1.5 | | V | |
| V _{OHV} | Minimum V _{CC} Droop (Notes 5, 6) | 5.0 | V _{OH} -1.0 | V _{OH} -1.8 | | V | |
| V _{IHD} | Minimum High Dynamic Input Voltage Level (Notes 5, 8) | 5.5 | 1.6 | 2.0 | 2.0 | 2.0 | V |
| V _{ILD} | Maximum Low Dynamic Input Voltage Level (Notes 5, 8) | 5.5 | 1.4 | 0.8 | 0.8 | 0.8 | V |

Note 5: Worst case package.

Note 6: Maximum number of outputs that can switch simultaneously is n. (n-1) outputs are switched LOW and one output held LOW.

Note 7: Maximum number of outputs that can switch simultaneously is n. (n-1) outputs are switched HIGH and one output held HIGH.

Note 8: Maximum number of data inputs (n) switching. (n-1) input switching 0V to 3V. Input under test switching 3V to threshold (V_{ILD}).

AC Electrical Characteristics

Normal Operation:

| Symbol | Parameter | V _{CC} (V) (Note 9) | Commercial | | | Military | | Commercial | | Units |
|------------------|--------------------------------|------------------------------------|--|-----|------|---|------|--|------|-------|
| | | | T _A = +25°C C _L = 50 pF | | | T _A = -55°C to +125°C C _L = 50 pF | | T _A = -40°C to +85°C C _L = 50 pF | | |
| | | | Min | Typ | Max | Min | Max | Min | Max | |
| t _{PLH} | Propagation Delay Data to Q | 5.0 | 2.5 | | 9.0 | 2.5 | 10.5 | 2.5 | 9.8 | ns |
| t _{PHL} | | | 2.5 | | 9.0 | 2.5 | 10.5 | 2.5 | 9.8 | |
| t _{PLZ} | Disable Time | 5.0 | 1.5 | | 10.2 | 1.5 | 11.2 | 1.5 | 10.7 | ns |
| t _{PHZ} | | | 1.5 | | 10.2 | 1.5 | 11.2 | 1.5 | 10.7 | |
| t _{PZL} | Enable Time | 5.0 | 2.0 | | 11.8 | 2.0 | 13.5 | 2.0 | 12.8 | ns |
| t _{PZH} | | | 2.0 | | 9.5 | 2.0 | 11.5 | 2.0 | 10.5 | |

Note 9: Voltage Range 5.0 is 5.0V ±0.5V.

AC Electrical Characteristics

Scan Test Operation:

| Symbol | Parameter | V _{CC} (V) (Note 10) | Commercial | | | Military | | Commercial | | Units |
|------------------|---|-------------------------------------|--|-----|------|---|------|--|------|-------|
| | | | T _A = +25°C C _L = 50 pF | | | T _A = -55°C to +125°C C _L = 50 pF | | T _A = -40°C to +85°C C _L = 50 pF | | |
| | | | Min | Typ | Max | Min | Max | Min | Max | |
| t _{PLH} | Propagation Delay | 5.0 | 3.5 | | 13.2 | 3.5 | 15.8 | 3.5 | 14.5 | ns |
| t _{PHL} | TCK to TDO | | 3.5 | | 13.2 | 3.5 | 15.8 | 3.5 | 14.5 | |
| t _{PLZ} | Disable Time | 5.0 | 2.5 | | 11.5 | 2.5 | 12.8 | 2.5 | 11.9 | ns |
| t _{PHZ} | TCK to TDO | | 2.5 | | 11.5 | 2.5 | 12.8 | 2.5 | 11.9 | |
| t _{PZL} | Enable Time | 5.0 | 3.0 | | 14.5 | 3.0 | 16.7 | 3.0 | 15.8 | ns |
| t _{PZH} | TCK to TDO | | 3.0 | | 14.5 | 3.0 | 16.7 | 3.0 | 15.8 | |
| t _{PLH} | Propagation Delay | 5.0 | 5.0 | | 18.0 | 5.0 | 21.7 | 5.0 | 19.8 | ns |
| t _{PHL} | TCK to Data Out During Update-DR State | | 5.0 | | 18.0 | 5.0 | 21.7 | 5.0 | 19.8 | |
| t _{PLH} | Propagation Delay | 5.0 | 5.0 | | 18.6 | 5.0 | 21.2 | 5.0 | 20.2 | ns |
| t _{PHL} | TCK to Data Out During Update-IR State | | 5.0 | | 18.6 | 5.0 | 21.2 | 5.0 | 20.2 | |
| t _{PLH} | Propagation Delay | 5.0 | 5.5 | | 19.9 | 5.5 | 23.0 | 5.5 | 21.5 | ns |
| t _{PHL} | TCK to Data Out During Test Logic Reset State | | 5.5 | | 19.9 | 5.5 | 23.0 | 5.5 | 21.5 | |
| t _{PLZ} | Propagation Delay | 5.0 | 4.0 | | 16.4 | 4.0 | 19.6 | 4.0 | 18.2 | ns |
| t _{PHZ} | TCK to Data Out During Update-DR State | | 4.0 | | 16.4 | 4.0 | 19.6 | 4.0 | 18.2 | |
| t _{PLZ} | Propagation Delay | 5.0 | 5.0 | | 19.5 | 5.0 | 22.4 | 5.0 | 20.8 | ns |
| t _{PHZ} | TCK to Data Out During Update-IR State | | 5.0 | | 19.5 | 5.0 | 22.4 | 5.0 | 20.8 | |
| t _{PLZ} | Propagation Delay | 5.0 | 5.0 | | 19.9 | 5.0 | 23.3 | 5.0 | 21.5 | ns |
| t _{PHZ} | TCK to Data Out During Test Logic Reset State | | 5.0 | | 19.9 | 5.0 | 23.3 | 5.0 | 21.5 | |
| t _{PZL} | Propagation Delay | 5.0 | 5.0 | | 18.9 | 5.0 | 22.6 | 5.0 | 20.9 | ns |
| t _{PZH} | TCK to Data Out During Update-DR State | | 5.0 | | 18.9 | 5.0 | 22.6 | 5.0 | 20.9 | |

AC Electrical Characteristics (Continued)

Scan Test Operation:

| Symbol | Parameter | V _{CC} (V) (Note 10) | Commercial | | | Military | | Commercial | | Units |
|------------------|---|-------------------------------------|--|------|-----|---|-----|--|-----|-------|
| | | | T _A = +25°C C _L = 50 pF | | | T _A = -55°C to +125°C C _L = 50 pF | | T _A = -40°C to +85°C C _L = 50 pF | | |
| | | | Min | Typ | Max | Min | Max | Min | Max | |
| t _{PZL} | Propagation Delay | 5.0 | 6.5 | 22.4 | 6.5 | 26.2 | 6.5 | 24.2 | ns | |
| t _{PZH} | TCK to Data Out During Update-IR State | | 6.5 | 22.4 | 6.5 | 26.2 | 6.5 | 24.2 | | |
| t _{PZL} | Propagation Delay | 5.0 | 7.0 | 23.8 | 7.0 | 27.4 | 7.0 | 25.7 | ns | |
| t _{PZH} | TCK to Data Out During Test Logic Reset State | | 7.0 | 23.8 | 7.0 | 27.4 | 7.0 | 25.7 | | |

Note 10: Voltage Range 5.0 is 5.0V ±0.5V.

Note 11: All Propagation Delays involving TCK are measured from the falling edge of TCK.

AC Operating Requirements

Scan Test Operation:

| Symbol | Parameter | V _{CC} (V) (Note 12) | Commercial | | | Military | | Commercial | | Units |
|----------------|---|-------------------------------------|--|--|------|--|------|---|----|-------|
| | | | T _A = +25°C C _L = 50 pF | | | T _A = -55°C to +125°C C _L = 50 pF | | T _A = -40°C to +85°C C _L = 50 pF | | |
| | | | Guaranteed Minimum | | | | | | | |
| t _s | Setup Time, H or L Data to TCK (Note 13) | 5.0 | 3.0 | | 3.0 | | 3.0 | | ns | |
| t _H | Hold Time, H or L TCK to Data (Note 13) | 5.0 | 4.5 | | 5.0 | | 4.5 | | ns | |
| t _s | Setup Time, H or L \overline{AOE}_n , \overline{BOE}_n to TCK (Note 15) | 5.0 | 3.0 | | 3.0 | | 3.0 | | ns | |
| t _H | Hold Time, H or L TCK to \overline{AOE}_n , \overline{BOE}_n (Note 15) | 5.0 | 4.5 | | 4.5 | | 4.5 | | ns | |
| t _s | Setup Time, H or L Internal AOE, BOE, to TCK (Note 14) | 5.0 | 3.0 | | 3.0 | | 3.0 | | ns | |
| t _H | Hold Time, H or L TCK to Internal AOE, BOE (Note 14) | 5.0 | 3.0 | | 3.0 | | 3.0 | | ns | |
| t _s | Setup Time, H or L TMS to TCK | 5.0 | 8.0 | | 8.0 | | 8.0 | | ns | |
| t _H | Hold Time, H or L TCK to TMS | 5.0 | 2.0 | | 2.0 | | 2.0 | | ns | |
| t _s | Setup Time, H or L TDI to TCK | 5.0 | 4.0 | | 4.0 | | 4.0 | | ns | |
| t _H | Hold Time, H or L TCK to TDI | 5.0 | 4.5 | | 4.5 | | 4.5 | | ns | |
| t _w | Pulse Width TCK | 5.0 | | | | | | | | |
| | H | | 15.0 | | 15.0 | | 15.0 | | ns | |
| | L | | 5.0 | | 5.0 | | 5.0 | | ns | |

AC Operating Requirements (Continued)

Scan Test Operation:

| Symbol | Parameter | V _{CC} (V) (Note 12) | Commercial | Military | Commercial | Units |
|--------------------|--------------------------------|-------------------------------------|--|--|---|-------|
| | | | T _A = +25°C C _L = 50 pF | T _A = -55°C to +125°C C _L = 50 pF | T _A = -40°C to +85°C C _L = 50 pF | |
| Guaranteed Minimum | | | | | | |
| f _{max} | Maximum TCK Clock Frequency | 5.0 | 25 | 25 | 25 | MHz |
| T _{PU} | Wait Time, Power Up to TCK | 5.0 | 100 | 100 | 100 | ns |
| T _{DN} | Power Down Delay | 0.0 | 100 | 100 | 100 | ms |

Note 12: Voltage Range 5.0 is 5.0V ±0.5V.

All Input Timing Delays involving TCK are measured from the rising edge of TCK.

Note 13: This delay represents the timing relationship between the data input and TCK at the associated scan cells numbered 0-8, 9-17, 18-26 and 27-35.

Note 14: This delay represents the timing relationship between AOE/BOE and TCK for scan cells 36 and 39 only.

Note 15: Timing pertains to BSR 37, 38, 40 and 41 only.

Extended AC Electrical Characteristics

| Symbol | Parameter | T _A = Com V _{CC} = Com C _L = 50 pF 18 Outputs Switching (Note 17) | | | T _A = Mil V _{CC} = Mil C _L = 50 pF 18 Outputs Switching (Note 17) | | T _A = Com V _{CC} = Com C _L = 250 pF (Note 7) | | T _A = Mil V _{CC} = Mil C _L = 250 pF (Note 7) | | Units |
|---------------------------------|--------------------------------------|---|-----|------|---|------|--|------|--|------|-------|
| | | Min | Typ | Max | Min | Max | Min | Max | Min | Max | |
| t _{PLH} | Propagation Delay | 3.0 | | 11.0 | 3.0 | 11.5 | 4.0 | 13.0 | 4.0 | 14.0 | ns |
| t _{PHL} | Data to Output | 3.0 | | 11.0 | 3.0 | 11.5 | 4.0 | 15.0 | 4.0 | 16.0 | ns |
| t _{PZH} | Output Enable Time | 2.5 | | 11.5 | 2.5 | 12.5 | (Note 19) | | (Note 19) | | ns |
| t _{PZL} | | 2.5 | | 14.0 | 2.5 | 14.5 | | | | | ns |
| t _{PHZ} | Output Disable Time | 2.0 | | 11.5 | 2.0 | 12.0 | (Note 20) | | (Note 20) | | ns |
| t _{PLZ} | | 2.0 | | 11.5 | 2.0 | 12.0 | | | | | ns |
| t _{OSSLH} (Note 16) | Pin to Pin Skew HL Data to Output | | 0.5 | 1.0 | | | 1.0 | | | | ns |
| t _{OSLH} (Note 16) | Pin to Pin Skew LH Data to Output | | 0.5 | 1.0 | | | 1.0 | | | | ns |

Note 16: Skew is defined as the absolute value of the difference between the actual propagation delays for any two separate outputs of the same device. The specification applies to any outputs switching HIGH to LOW (t_{OSSLH}), LOW to HIGH (t_{OSLH}), or any combination switching LOW to HIGH and/or HIGH to LOW.

Note 17: This specification is guaranteed but not tested. The limits apply to propagation delays for all paths described switching in phase (i.e., all low-to-high, high-to-low, etc.).

Note 18: This specification is guaranteed but not tested. The limits represent propagation delays with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load. This specification pertains to single output switching only.

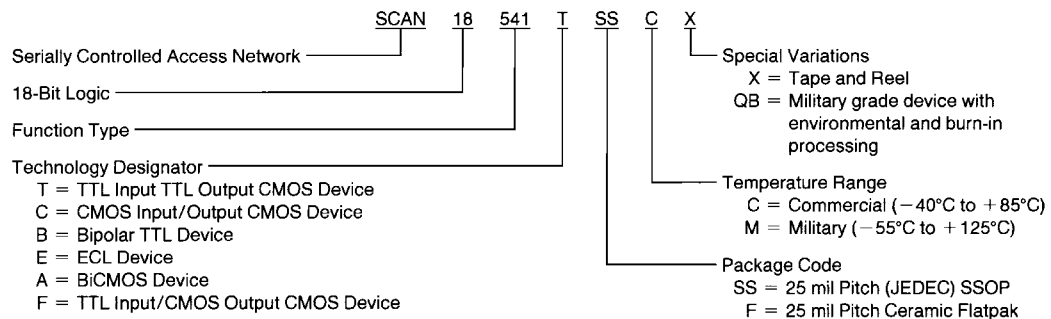
Note 19: 3-STATE delays are load dominated and have been excluded from the datasheet.

Note 20: The Output Disable Time is dominated by the RC network (500Ω, 250 pF) on the output and has been excluded from the datasheet.

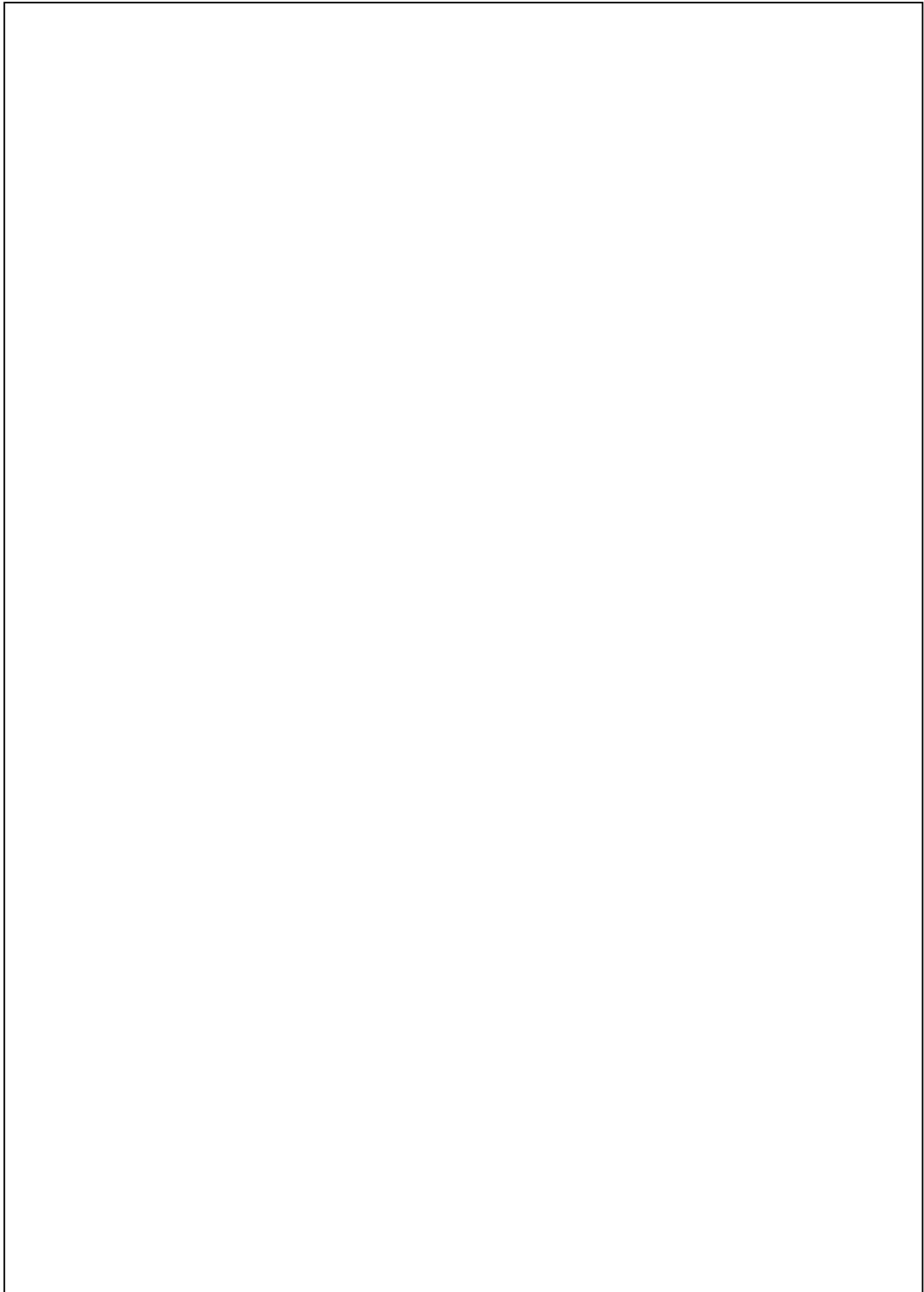
Capacitance

| Symbol | Parameter | Typ | Units | Conditions |
|------------------|----------------------------------|------|-------|------------------------|
| C _{IN} | Input Pin Capacitance | 4.0 | pF | V _{CC} = 5.0V |
| C _{OUT} | Output Pin Capacitance | 13.0 | pF | V _{CC} = 5.0V |
| C _{PD} | Power Dissipation Capacitance | 34.0 | pF | V _{CC} = 5.0V |

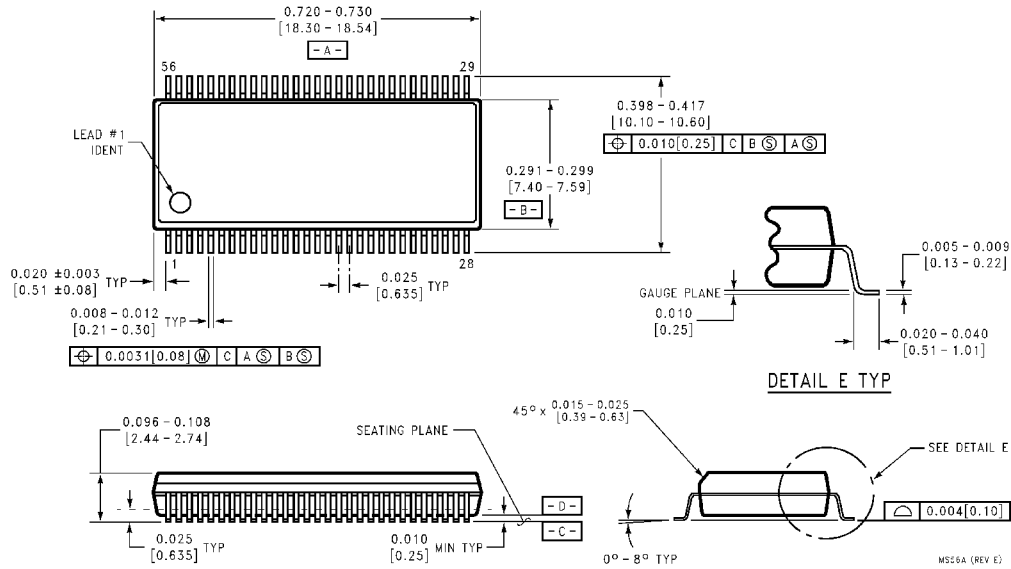
Ordering Information Scan Series



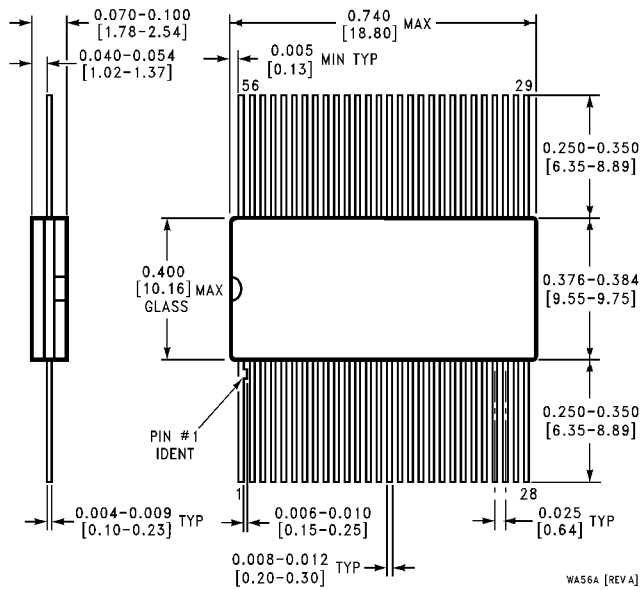
DS010965-24



Physical Dimensions inches (millimeters) unless otherwise noted



56-Lead SSOP (0.300" Wide) (SS)
Order Number SCAN18541TSSC or SCAN18541TSSCX
Package Number MS56A



56-Lead Ceramic Flatpak (F)
Order Number SCAN18541TFMQB
Package Number WA56A

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